

RoHS Compliant Product  
A suffix of "-C" specifies halogen and lead-free

## DESCRIPTION

The STT2605-C is the highest performance trench P-Ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The STT2605-C meet the RoHS and Green Product requirement with full function reliability approved.

## FEATURES

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge

## MARKING



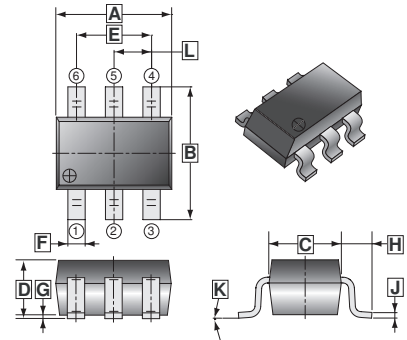
## PACKAGE INFORMATION

Package	MPQ	Leader Size
TSOP-6	3K	7 inch

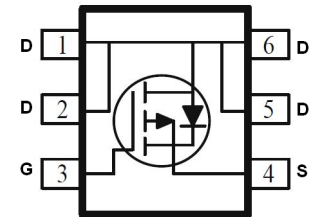
## ORDER INFORMATION

Part Number	Type
STT2605-C	Lead (Pb)-free and Halogen-free

## TSOP-6



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0	0.10
B	2.60	3.00	H	0.60	REF.
C	1.40	1.80	J	0.12	REF.
D	1.45	MAX.	K	0°	10°
E	1.90	REF.	L	0.95	REF.
F	0.30	0.50			



## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings		Unit	
		$t \leq 10\text{sec}$	Steady State		
Drain-Source Voltage	$V_{DS}$	-30		V	
Gate-Source Voltage	$V_{GS}$	$\pm 20$		V	
Continuous Drain Current, @ $V_{GS} = -10\text{V}$ <sup>1</sup>	$I_D$	$T_A=25^\circ\text{C}$	-5	-3.9	A
		$T_A=70^\circ\text{C}$	-4	-3.1	
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	-20		A	
Total Power Dissipation	$P_D$	2		W	
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~150		$^\circ\text{C}$	
Thermal Resistance Ratings					
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	$t \leq 10\text{sec}$	62.5		$^\circ\text{C/W}$
		Steady State	110		
Thermal Resistance Junction-Ambient <sup>2</sup>	$R_{\theta JA}$	156			
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	70			

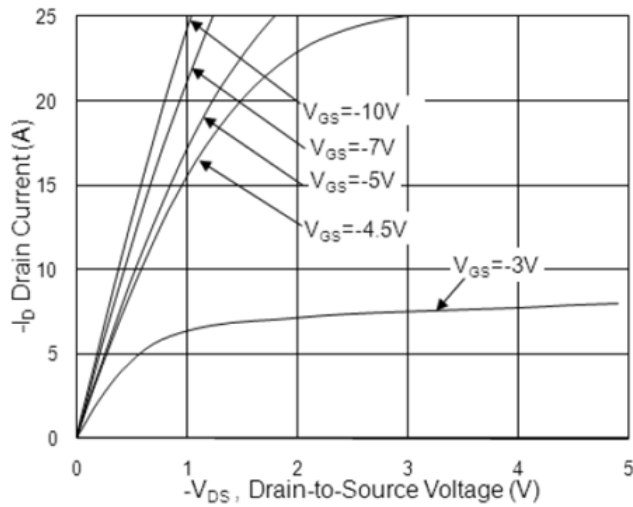
**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$BV_{DSS}$	-30	-	-	V	$V_{GS}=0, I_D = -250\mu\text{A}$
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-1.5	-2.5	V	$V_{DS}=V_{GS}, I_D = -250\mu\text{A}$
Forward Transconductance	$g_{fs}$	-	11	-	S	$V_{DS} = -5\text{V}, I_D = -3\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS} = \pm 20\text{V}$
Drain-Source Leakage Current	$I_{DSS}$	$T_J=25^\circ\text{C}$	-	-1	uA	$V_{DS} = -24\text{V}, V_{GS}=0$
		$T_J=55^\circ\text{C}$	-	-5		
Static Drain-Source On-Resistance <sup>4</sup>	$R_{DS(ON)}$	-	42	52	m $\Omega$	$V_{GS} = -10\text{V}, I_D = -3\text{A}$
		-	54	80		$V_{GS} = -4.5\text{V}, I_D = -2\text{A}$
Total Gate Charge	$Q_g$	-	6.4	-	nC	$I_D = -3\text{A}$ $V_{DS} = -15\text{V}$ $V_{GS} = -4.5\text{V}$
Gate-Source Charge	$Q_{gs}$	-	2.3	-		
Gate-Drain Charge	$Q_{gd}$	-	1.9	-		
Turn-on Delay Time	$T_{d(on)}$	-	2.8	-	nS	$V_{DD} = -15\text{V}$ $I_D = -3\text{A}$ $V_{GS} = -10\text{V}$ $R_G = 3.3\Omega$
Rise Time	$T_r$	-	8.4	-		
Turn-off Delay Time	$T_{d(off)}$	-	39	-		
Fall Time	$T_f$	-	6	-		
Input Capacitance	$C_{iss}$	-	583	-	pF	$V_{GS}=0$ $V_{DS} = -15\text{V}$ $f=1\text{MHz}$
Output Capacitance	$C_{oss}$	-	100	-		
Reverse Transfer Capacitance	$C_{rss}$	-	80	-		
<b>Source-Drain Diode</b>						
Continuous Source Current <sup>1</sup>	$I_S$	-	-	-3.9	A	
Pulsed Source Current <sup>3</sup>	$I_{SM}$	-	-	-20		
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	-	-0.8	-1.2	V	$V_{GS}=0, I_S = -1\text{A}, T_J=25^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	-	7.8	-	nS	$I_F = -3\text{A}, dI/dt=100\text{A}/\mu\text{s}$
Reverse Recovery Charge	$Q_{rr}$	-	2.5	-	nC	$T_J=25^\circ\text{C}$

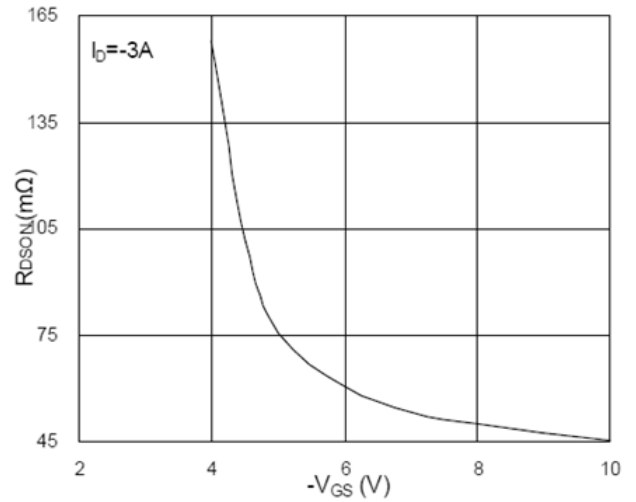
Notes:

1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.
2. When mounted on Min. copper pad.
3. The power dissipation is limited by 150°C junction temperature, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
4. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

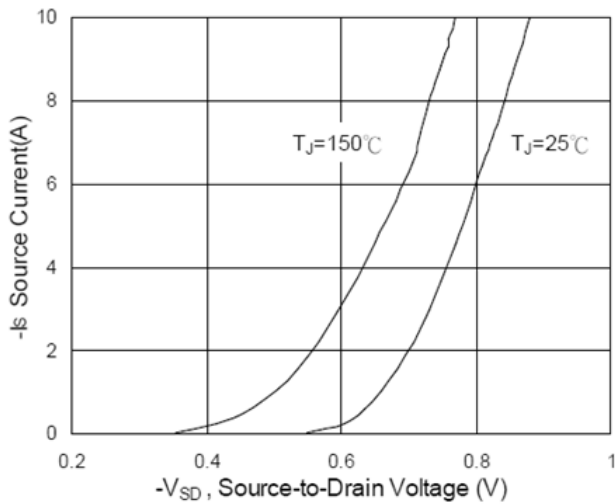
**CHARACTERISTICS CURVE**



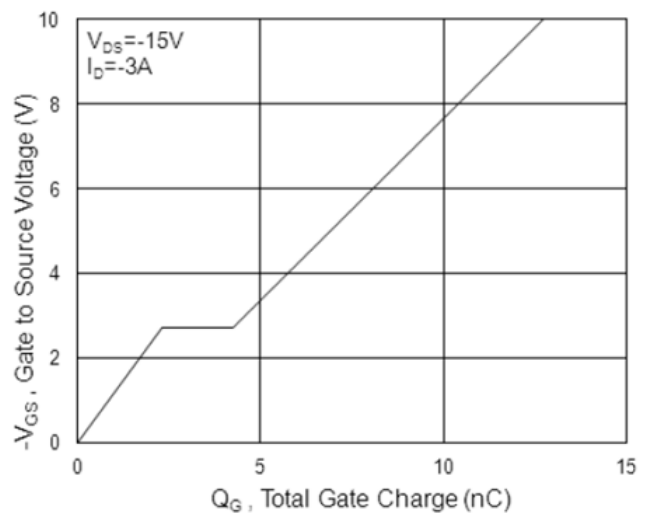
**Fig.1 Typical Output Characteristics**



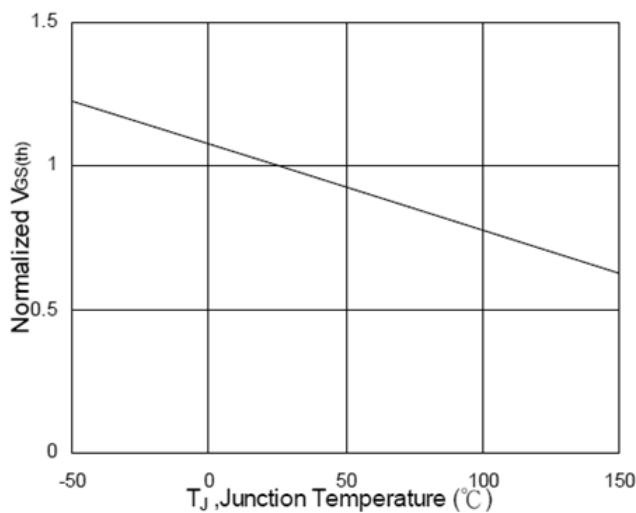
**Fig.2 On-Resistance vs. Gate-Source**



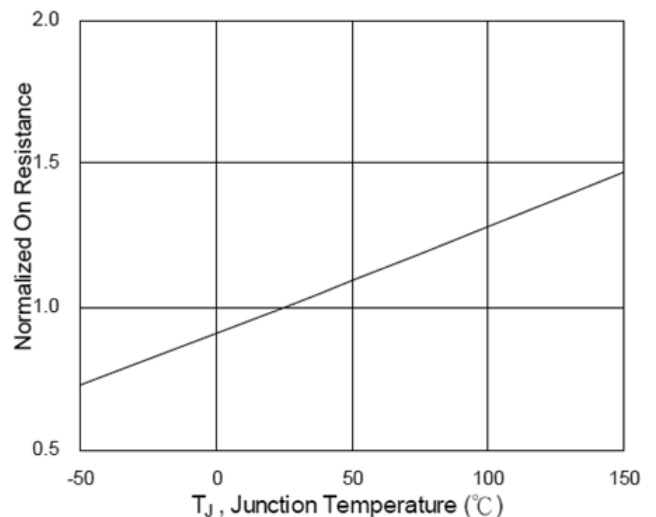
**Fig.3 Forward Characteristics of Reverse**



**Fig.4 Gate-Charge Characteristics**

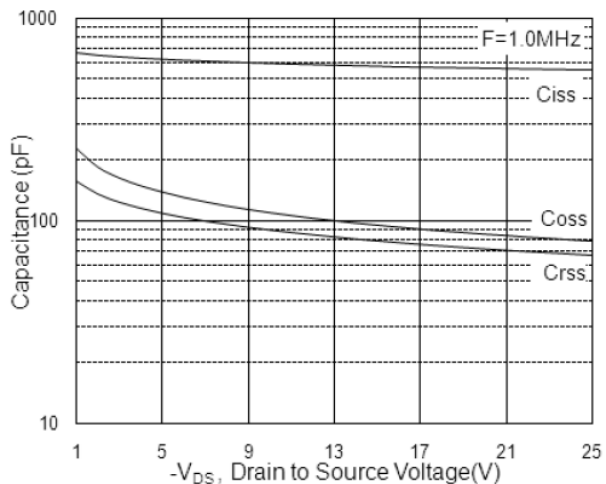


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

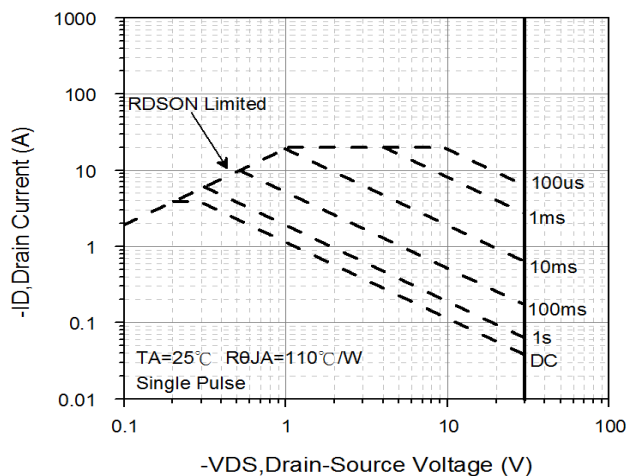


**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

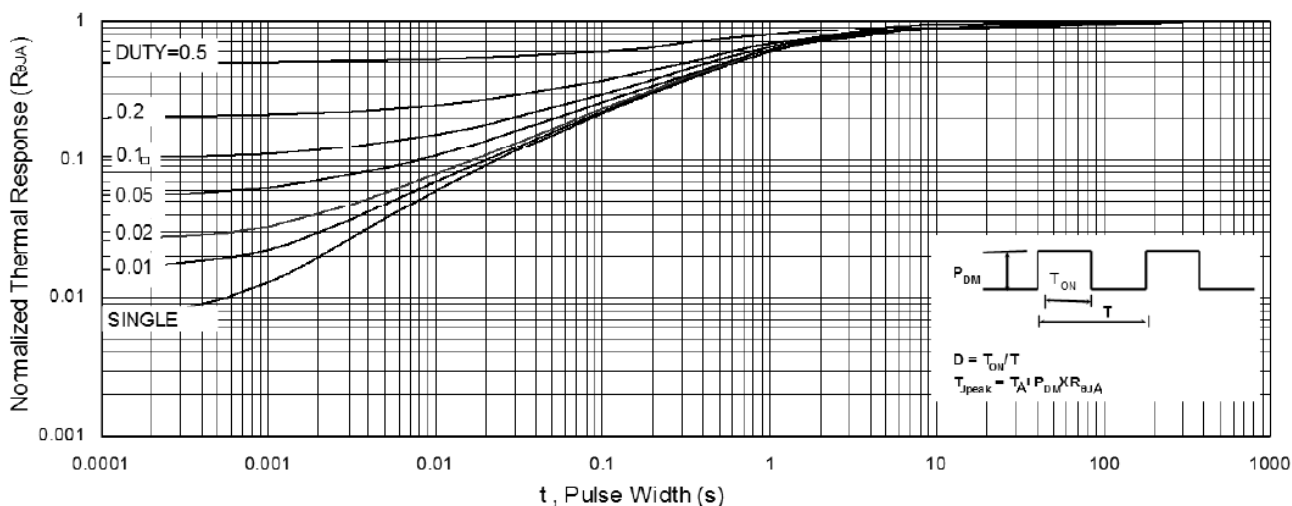
**CHARACTERISTICS CURVE**



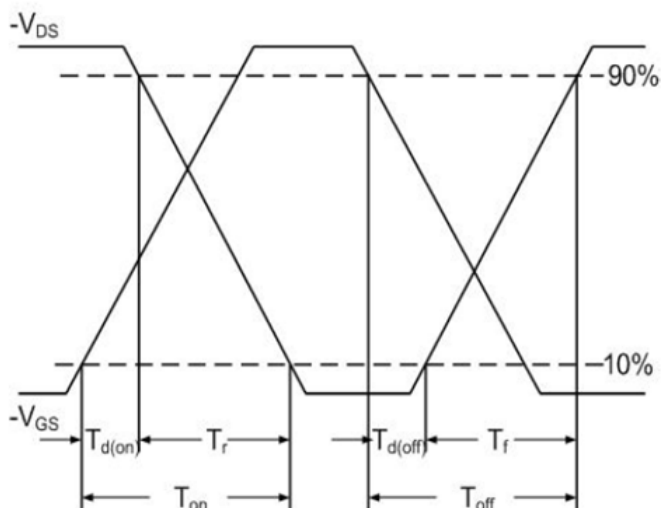
**Fig.7 Capacitance**



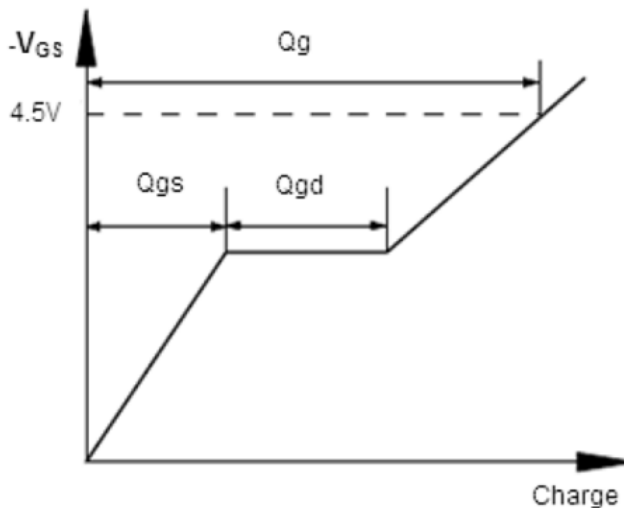
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Gate Charge Waveform**